

Special Issue

Information Optics

Message from the Guest Editors

This sub-session on “Optics and Lasers” covers topics in information optics. Modern information optics has been applied in many important areas, such as 3D inspection, 3D microscopy, metrology and profilometry, augmented reality, and industrial informatics. These topics are not meant to be exhaustive but rather to reflect current selected interests in modern information optics to information technology. Your contributions toward the sub-session are highly appreciated. Please feel free to contact us if you have any questions regarding the sub-session.

Prof. Liangcai Cao

Guest Editors

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Deadline for manuscript submissions

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As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal *Applied Sciences* has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

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